DATA SHEET

ARV321/ARV322 5%; 1% Array chip resistors size 2 × 0402

Product specification
Supersedes data of 30th August 2000

2001 Apr 28 Rev.2



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FEATURES

- · Reduced size of final equipment
- · Low assembly costs
- Higher component and equipment reliability.

APPLICATIONS

- Camcorders
- · Cellular phones
- · Hearing aids
- · Advanced pagers
- · Palmtop computers.

DESCRIPTION

The resistors are constructed on a high grade ceramic body (aluminium oxide). Internal metal electrodes are added at each end and connected by a resistive paste which is applied to the top surface of the substrate. The composition of the paste is adjusted to give the approximate resistance required and the value is trimmed to within tolerance, by laser cutting of this resistive layer.

The resistive layer is covered with a protective coating and printed with the resistance value. Finally, external end terminations are added. For ease of soldering the outer layer of these end terminations is a lead-tin alloy.

QUICK REFERENCE DATA

DESCRIPTION	VALUE		
DESCRIPTION	ARV321	ARV322	
Resistance range and E-series 10 Ω to 1 M Ω ; jumper; E2 series			
Resistance tolerance	±5%	±1%	
Temperature coefficient	≤±200 × 10 ⁻⁶ /K		
Absolute maximum dissipation per resistive element at $T_{amb} = 70 ^{\circ}\text{C}$	0.063 W		
Maximum permissible voltage	50 V (DC	or RMS)	
Operating temperature range	−55 to +125 °C		
Climatic category (IEC 60068)	55/12	25/56	
Basic specification	IEC 60115-8		

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ORDERING INFORMATION

Table 1 Ordering code indicating resistor type

			ORDERING CODE 2350 0	
TYPE	RESISTANCE VALUE	TOL. (%)	PAPER TAPE ON REEL	
		(73)	10 000 units	
ARV321	10 Ω to 1 MΩ	5	13 11	
ARV322	10 22 10 1 10122	1	13 2	
Jumper 0 Ω				
ARV321; note 1	_	_	13 91001	

Note

1. The jumper has a maximum resistance R_{max} = 50 $m\Omega$ and a rated current I_R = 1 A.

Ordering code (12NC)

- The resistors have a 12-digit ordering code starting with 2350 0
- The subsequent three or four digits indicate the resistor termination style, tolerance and packing; see Table 1.
- The remaining digits indicate the resistance value:
 - The first 2 digits for 5% or 3 digits for 1% tolerance products indicate the resistance value.
 - The last digit indicates the resistance decade in accordance with Table 2.

Table 2 Last digit of 12NC

RESISTANCE DECADE	LAST DIGIT
10 to 91 Ω	9
100 to 910 Ω	1
1 to 9.1 kΩ	2
10 to 91 kΩ	3
100 to 910 kΩ	4
1 ΜΩ	5

ORDERING EXAMPLE

The ordering code of an ARV321 convex type array chip resistor, value 100Ω , 5% tolerance, supplied on paper tape of 10000 units per reel is: 2350 013 11101.

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FUNCTIONAL DESCRIPTION

Product characterization

Standard values of nominal resistance are taken from the E24 or E96 series for resistors with a tolerance of $\pm 5\%$ or $\pm 1\%$. The values of the E24/E96 series are in accordance with "IEC publication 60063".

Limiting values

TYPE	LIMITING VOLTAGE ⁽¹⁾ (V)	LIMITING POWER (W)	
ARV321	50	0.063	
ARV322	50	0.003	

Note

 This is the maximum voltage that may be continuously applied to the resistor element, see "IEC publication 60115-8".

DERATING

The power that the resistor can dissipate depends on the operating ambient temperature; see Fig.1.

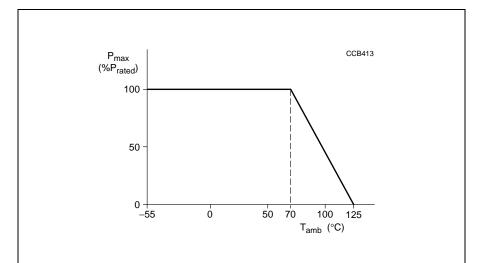


Fig.1 Maximum dissipation (P_{max}) in percentage of rated power as a function of the operating ambient temperature (T_{amb}).

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MECHANICAL DATA

Mass per 100 units

TYPE	MASS (g)
ARV321	0.095
ARV322	0.095

Marking

There is no marking on these products.

PACKAGE MARKING

The packing is marked and includes resistance value, tolerance, catalogue number, quantity, production period, batch number and source code.

Outlines

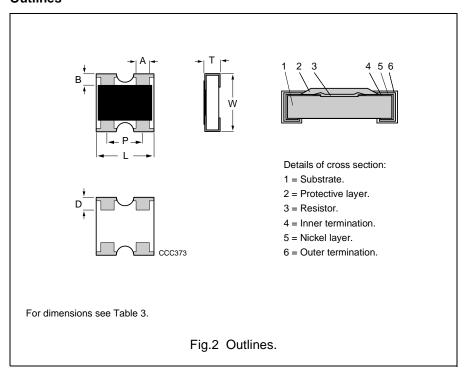


Table 3 Physical dimensions; see Fig.2

CVMDOL	ARV321	LIMIT		
SYMBOL	VALUE	TOL.	UNIT	
L	1.00	±0.10	mm	
W	1.00	±0.10	mm	
Т	0.35	±0.10	mm	
Α	0.25	±0.15	mm	
В	0.20		mm	
Р	0.65 ±0.15 m		mm	
D	0.25	25 ±0.15 mm		

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TESTS AND REQUIREMENTS

Essentially all tests are carried out in accordance with the schedule of "IEC publication 60115-8", category LCT/UCT/56 (rated temperature range: Lower Category Temperature, Upper Category Temperature; damp heat, long term, 56 days). The testing also covers the requirements specified by EIA and EIAJ.

The tests are carried out in accordance with IEC publication 60068, "Recommended basic climatic and mechanical robustness testing procedure for electronic components" and under standard atmospheric conditions according to "IEC 60068-1", subclause 5.3.

Unless otherwise specified the following values apply:

Temperature: 15 °C to 35 °C Relative humidity: 25% to 75% Air pressure: 86 kPa to 106 kPa (860 mbar to 1060 mbar).

In Table 4 the tests and requirements are listed with reference to the relevant clauses of "IEC publications 60115-8 and 60068"; a short description of the test procedure is also given.

In some instances deviations from the IEC recommendations were necessary for our method of specifying.

Table 4 Test procedures and requirements

IEC	IEC IEC		TEST PROCEDURE	REQUIREMENTS	
60115-8 CLAUSE	60068-2 TEST METHOD	TEST		ARV321	ARV322
Tests in a	ccordance	with the schedule	of IEC publication 60115-8		
4.4.1		visual examination			ean surface; damage
4.5		resistance	applied voltage (+0/–10%): $R < 10 \ \Omega: \ 0.1 \ V$ $10 \ \Omega \le R < 100 \ \Omega: \ 0.3 \ V$ $100 \ \Omega \le R < 1 \ k\Omega: \ 1 \ V$ $1 \ k\Omega \le R < 10 \ k\Omega: \ 3 \ V$ $10 \ k\Omega \le R < 100 \ k\Omega: \ 10 \ V$ $100 \ k\Omega \le R < 1 \ M\Omega: \ 25 \ V$ $R \ge 1 \ M\Omega: \ 50 \ V$	R – R _{nom} : max. ±5%	R – R _{nom} : max. ±1%
4.18	20 (Tb)	resistance to soldering heat	unmounted chips; 10 ±1 s; 260 ±5 °C		e damage (1% +0.05 Ω)
4.29	45 (Xa)	component solvent resistance	isopropyl alcohol or H ₂ O followed by brushing in accordance with "MIL 202 F"	no visible	e damage
4.17	20 (Ta)	solderability	unmounted chips completely immersed for 2 \pm 0.5 s in a solder bath at 235 \pm 2 °C	J ,	:95% covered); e damage
4.7		voltage proof on insulation	maximum voltage (RMS) during 1 minute, metal block method	no breakdow	n or flashover
4.13		short time overload	room temperature; $P = 6.25 \times P_n$; 5 s (V \leq 2 \times V _{max})	ΔR/R max.: :	±(2% +0.1 Ω)
4.33		bending	resistors mounted on a 90 mm glass epoxy resin PCB (FR4), bending: 5 mm		e damage (1% +0.05 Ω)
4.19	14 (Na)	rapid change of temperature	30 minutes at LCT and 30 minutes at UCT; 5 cycles		e damage (2% +0.05 Ω)

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IEC IEC				REQUIREMENTS	
60115-8 CLAUSE	60068-2 TEST METHOD	TEST	PROCEDURE	ARV321	ARV322
4.24.2	3 (Ca)	damp heat (steady state)	56 days; 40 ±2 °C; 93 +2/–3% RH; loaded with 0.01 P _n	Δ R/R max.: \pm (3% +0.1 Ω)	Δ R/R max.: \pm (2% +0.1 Ω)
4.25.1		endurance	1000 +48/–0 hours; 70 ±2 °C; loaded with P _n or V _{max} ; 1.5 hours on and 0.5 hours off	Δ R/R max.: $\pm (3\% + 0.1 \Omega)$	Δ R/R max.: \pm (2% +0.1 Ω)
4.23.2	27 (Ba)	endurance at upper category temperature	1000 +48/-0 hours; no load	Δ R/R max.: $\pm (3\% + 0.1 \Omega)$	Δ R/R max.: \pm (2% +0.1 Ω)
4.8.4.2		temperature coefficient	at 20/LCT/20 °C and 20/UCT/20 °C	≤±200 >	< 10 ⁻⁶ /K
Other test	s in accord	ance with IEC 60	115 clauses and IEC 60068 test method		
4.17	20 (Ta)	solderability (after ageing)	8 hours steam or 16 hours 155 °C; unmounted chips completely immersed for 2 ±0.5 s in a solder bath at 235 ±2 °C	- ,	:95% covered); mage
4.6.1.1		insulation resistance	50 V (DC) after 1 minute, metal block method	R _{ins} min.	: 10 ³ MΩ
4.12		noise	IEC publication 60195 (measured with Quantech-equipment):		
			R ≤ 100 Ω	max. 0.316 μ	.V/V (-10 dB)
			$100 \Omega < R \le 1 k\Omega$	max. 1 μ\	//V (0 dB)
			1 kΩ < R ≤ 10 kΩ	max. 3 μV/	V (9.54 dB)
			$10 \text{ k}\Omega < \text{R} \le 100 \text{ k}\Omega$	max. 6 μV/\	/ (15.56 dB)
			100 kΩ < R \leq 1 MΩ	max. 10 μ\	//V (20 dB)
Other applicable tests					
(JIS) C 5202 7.9		endurance (under damp and load)	1000 +48/–0 hours; 40 ±2 °C; 93 +2/–3% RH; loaded with P _n or V _{max} ; 1.5 hours on and 0.5 hours off	Δ R/R max.: \pm (3% +0.1 Ω)	Δ R/R max.: \pm (2% +0.1 Ω)
EIA 575 3.13		leaching	unmounted chips; 60 ±1 s; 260 ±5 °C	good tinning	; no leaching
EIA/IS 703 4.5		load humidity	1 000 +48/–0 hours; 85 \pm 2 °C; 85 \pm 5% RH; loaded with 0.01 P _n or V _{max}	Δ R/R max.: \pm (3% +0.1 Ω)	Δ R/R max.: \pm (2% +0.1 Ω)

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REVISION HISTORY

Revision	Date	Change Notification	Description
Rev.2	2001 Apr 28	_	- Converted to Phycomp brand - Operation temperature range –55 to +125 °C added